Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination WANG ET AL. Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	C	US-			
	D	US-			
	Ε	US-			
	F	US-		-	
	G	US-		*	
	н	US-			
	-	US-	·		
	J	US-			
	К	US-			
	L	US-		·	
	М	US-			·

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	a					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Duenas, et al. FEMS Microbiology Letters, 1995, Vol. 125, pages 317-
	V	Swald & keff
	w	3-5-2005
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.